Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

SSM3K15FV

High Speed Switching Applications Analog Switch Applications

Optimum for high-density mounting in small packages

- Low on-resistance
 - : $R_{on} = 4.0 \Omega \text{ (max) } (@V_{GS} = 4 \text{ V})$
 - : $R_{on} = 7.0 \Omega \text{ (max) } (@V_{GS} = 2.5 \text{ V})$

Absolute Maximum Ratings (Ta = 25°C)

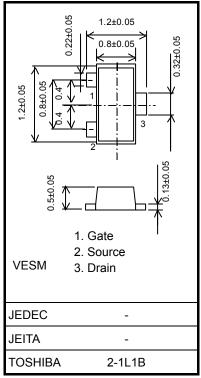
| Characteristics | | Symbol | Rating | Unit | |
|-------------------------------------|-------|-------------------------|------------------|------|--|
| Drain-source voltage | | V_{DS} | 30 | V | |
| Gate-source voltage | | V _{GSS} | ±20 | V | |
| Drain current | DC | I _D | 100 | mA | |
| | Pulse | I _{DP} | 200 | | |
| Drain power dissipation (Ta = 25°C) | | P _D (Note 1) | 150 | mW | |
| Channel temperature | | T _{ch} | 150 | °C | |
| Storage temperature | | T _{stg} | −55 ~ 150 | °C | |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

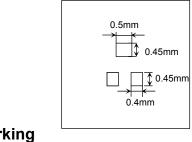
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling

Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Total rating, mounted on FR4 board (25.4 mm × 25.4 mm × 1.6 t)

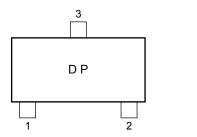


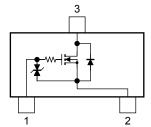
Weight: 0.0015 g (typ.)



Marking

Equivalent Circuit





Handling Precaution

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

Electrical Characteristics (Ta = 25°C)

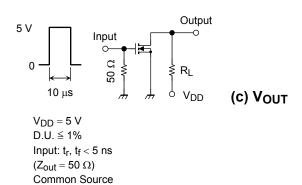
| Characteristics | | Symbol | Test Condition | Min | Тур. | Max | Unit |
|--------------------------------|---------------|----------------------|---|-----|------|-----|------|
| Gate leakage current | | I _{GSS} | $V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$ | _ | _ | ±1 | μА |
| Drain-source breakdown voltage | | V (BR) DSS | $I_D = 0.1 \text{ mA}, V_{GS} = 0$ | 30 | _ | _ | V |
| Drain cut-off curre | ent | I _{DSS} | V _{DS} = 30 V, V _{GS} = 0 | _ | _ | 1 | μА |
| Gate threshold vo | ltage | V _{th} | $V_{DS} = 3 \text{ V}, I_D = 0.1 \text{ mA}$ | 0.8 | _ | 1.5 | V |
| Forward transfer | admittance | Y _{fs} | $V_{DS} = 3 \text{ V}, I_D = 10 \text{ mA}$ | 25 | _ | _ | mS |
| Drain-Source on-resistance | | R _{DS (ON)} | I _D = 10 mA, V _{GS} = 4 V | _ | 2.2 | 4.0 | Ω |
| | | | I _D = 10 mA, V _{GS} = 2.5 V | _ | 4.0 | 7.0 | |
| Input capacitance | | C _{iss} | V _{DS} = 3 V, V _{GS} = 0, f = 1 MHz | _ | 7.8 | _ | pF |
| Reverse transfer capacitance | | C _{rss} | V _{DS} = 3 V, V _{GS} = 0, f = 1 MHz | _ | 3.6 | _ | pF |
| Output capacitance | | C _{oss} | V _{DS} = 3 V, V _{GS} = 0, f = 1 MHz | _ | 8.8 | _ | pF |
| Switching time | Turn-on time | t _{on} | V _{DD} = 5 V, I _D = 10 mA, V _{GS} = 0~5 V | _ | 50 | _ | ns |
| | Turn-off time | t _{off} | | _ | 180 | _ | |

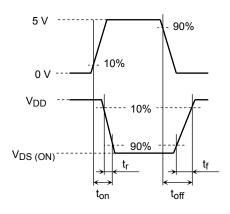
Switching Time Test Circuit

Ta = 25°C







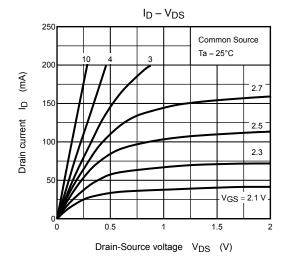


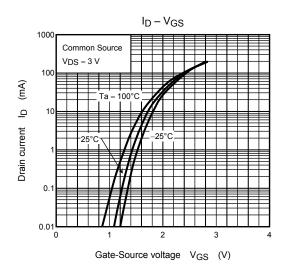
Precaution

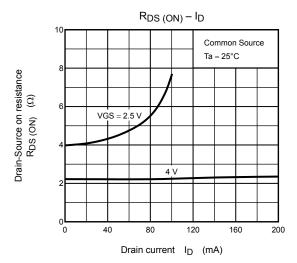
 V_{th} can be expressed as the voltage between gate and source when the low operating current value is I_D = 100 μ A for this product. For normal switching operation, $V_{GS~(on)}$ requires a higher voltage than V_{th} and $V_{GS~(off)}$ requires a lower voltage than V_{th} .

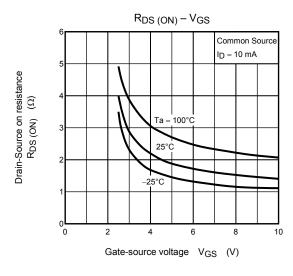
(The relationship can be established as follows: $V_{GS\ (off)} < V_{th} < V_{GS\ (on)}$)

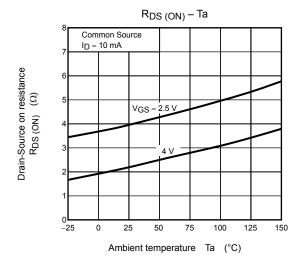
Please take this into consideration when using the device.

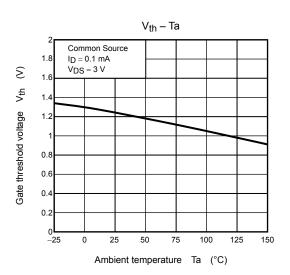


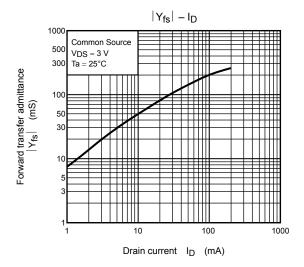


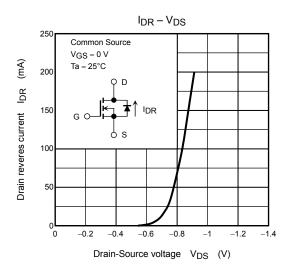


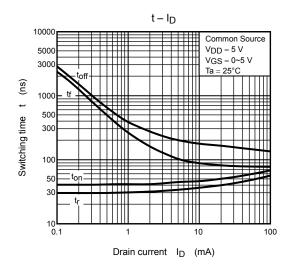


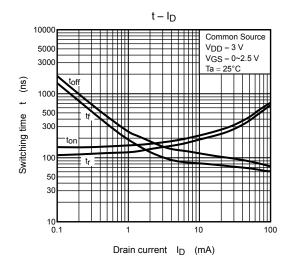


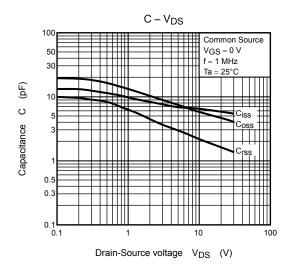


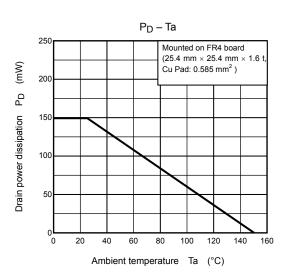












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20070701-EN GENERAL

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